Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10686553	WALSH, PATRICK JAY
	Examiner	Art Unit
	David Q Nguyen	2617

ORIGINAL		INTERNATIONAL CLASSIFICATION	
CLASS	SUBCLASS	CLAIMED	NON-CLAIMED
455	456.1	H 0 4 Q 7 / 20 (2006.01.01)	

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
455	456.2	456.3	456.6	411	
370	336				

NONE		**Total Claims Allowed:**	
(Assistant Examiner) (Date)		17	
/David Q Nguyen/	03/05/08	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner)	(Date)	1	1